

Search Notes**Application/Control No.**

10/565,949

Examiner

Hai H. Huynh

Applicant(s)/Patent under Reexamination

WEISS ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	295	3/27/2007	HHH
123	299	3/27/2007	HHH
123	305	3/27/2007	HHH
123	443	3/27/2007	HHH
123	325	3/27/2007	HHH
123	332	3/27/2007	HHH
123	406.23	3/27/2007	HHH
123	406.47	3/27/2007	HHH
update	search	9/10/2007	HHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	3/27/2007	HHH
	9/10/2007	HHH